



DMB54D0UV

N-CHANNEL ENHANCEMENT MODE MOSFET PLUS PNP TRANSISTOR

Features

- N-Channel MOSFET and PNP Transistor in One Package
- Low On-Resistance
- Very Low Gate Threshold Voltage, 1.0V max
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Ultra-Small Surface Mount Package
- ESD Protected MOSFET Gate up to 2kV
- Lead, Halogen and Antimony Free, RoHS Compliant (Note 1)
- "Green" Device (Note 2)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SOT563
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Copper lead frame.
 Solderable per MIL-STD-202, Method 208
- Weight: 0.006 grams (approximate)



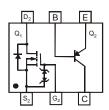








Bottom View



Top View Internal Schematic

Ordering Information (Note 3)

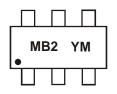
Part Number	Case	Packaging
DMB54D0UV-7	SOT563	3,000/Tape & Reel
DMB54D0UV-13	SOT563	10,000/Tape & Reel

SOT563

Notes:

- 1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. No purposely added lead. Halogen and Antimony free
- 2. Diodes Inc.'s "Green" policy can be found on our website at http://www.diodes.com.
- 3. For packaging details, go to our website at http://www.diodes.com.

Marking Information



MB2 = Marking Code YM = Date Code Marking Y = Year (ex: V = 2008) M = Month (ex: 9 = September)

Date Code Key

Year	2008	2009	20	10	2011	2012	2013	2014	20)15	2016	2017
Code	V	W		<	Υ	Z	Α	В	(С	D	E
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings – MOSFET, Q1 @T_A = 25°C unless otherwise specified

Character	stic	Symbol	Value	Units	
Drain-Source Voltage		V _{DSS}	50	V	
Gate-Source Voltage		V _{GSS}	±12	V	
Drain Current (Note 4)	Continuous	I _D	160	mA	
Pulsed Drain Current (Note 4)		I _{DM}	560	mA	

Maximum Ratings - PNP Transistor, Q2 @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Collector-Base Voltage	V _{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-45	V
Emitter-Base Voltage	V_{EBO}	-5.0	V
Collector Current	Ic	-100	mA

Thermal Characteristics, Total Device @T_A = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Total Power Dissipation (Note 4)	P_{D}	250	mW
Thermal Resistance, Junction to Ambient (Note 4)	$R_{ hetaJA}$	500	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C

Electrical Characteristics - MOSFET @TA = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 5)							
Drain-Source Breakdown Voltage	BV _{DSS}	50			V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}			10	μΑ	$V_{DS} = 50V, V_{GS} = 0V$	
Gate-Body Leakage	I _{GSS}		_	1.0 5.0	μА	$V_{GS} = \pm 8V, V_{DS} = 0V$ $V_{GS} = \pm 12V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(th)}	0.7	0.8	1.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
Static Drain-Source On-Resistance	R _{DS} (ON)		3.1	4	Ω	$V_{GS} = 4V, I_D = 100mA$	
Static Drain-Source On-Resistance			4	5		$V_{GS} = 2.5V, I_D = 80mA$	
Forward Transconductance	g FS	180			mS	$V_{DS} = 10V, I_D = 100mA,$ f = 1.0KHz	
DYNAMIC CHARACTERISTICS (Note 6)							
Input Capacitance	C _{iss}		25		pF	101/1/	
Output Capacitance	Coss		5		pF	$V_{DS} = 10V, V_{GS} = 0V,$ -f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	_	2.1	_	pF	11 = 1.UIVIDZ	

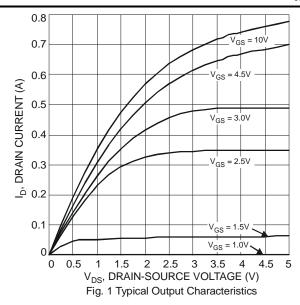
- 4. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.5. Short duration pulse test used to minimize self-heating effect.
- 6. Guaranteed by design. Not subject to product testing.

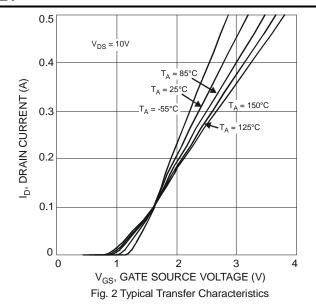


Electrical Characteristics - PNP Transistor @TA = 25°C unless otherwise specified

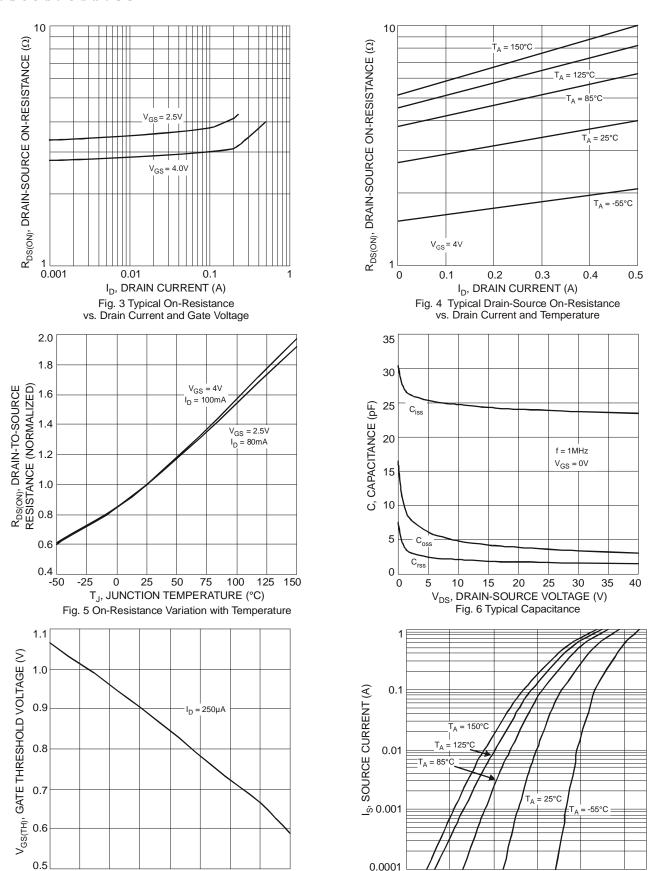
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
Collector-Base Breakdown Voltage (Note 5)	V _{(BR)CBO}	-50	I		V	$I_C = 10\mu A, I_B = 0$	
Collector-Emitter Breakdown Voltage (Note 5)	V _{(BR)CEO}	-45	I		V	$I_C = 10 \text{mA}, I_B = 0$	
Emitter-Base Breakdown Voltage (Note 5)	$V_{(BR)EBO}$	-5			>	$I_E = 1\mu A, I_C = 0$	
DC Current Gain (Note 5)	h _{FE}	220	290	475	l	$V_{CE} = -5.0V, I_{C} = -2.0mA$	
Collector-Emitter Saturation Voltage (Note 5)	V _{CE(SAT)}		_	-100	mV	$I_C = -10 \text{mA}, I_B = -0.5 \text{mA}$	
Concolor Emiliar Calaration Voltage (14010-0)	VCE(SAT)		_	-400	111 V	$I_C = -100 \text{mA}, I_B = -5.0 \text{mA}$	
Base-Emitter Saturation Voltage (Note 5)	V _{BE(SAT)}	_	-700	_	mV	$I_C = -10 \text{mA}, I_B = -0.5 \text{mA}$	
Base Emilier Galaration Voltage (Note o)	VBE(SAT)	_	-900	_	111 V	$I_C = -100 \text{mA}, I_B = -5.0 \text{mA}$	
Base-Emitter Voltage (Note 5)	V _{BE(ON)}	-600	_	-750	mV	$V_{CE} = -5.0V, I_{C} = -2.0mA$	
base-Emilier voltage (Note 9)	V BE(ON)	A BE(ON)	_	_	-820	111 V	$V_{CE} = -5.0V, I_{C} = -10mA$
Collector-Cutoff Current (Note 5)	lana		1	-15	nA	V _{CB} = -30V	
Collector-Cutoff Current (Note 3)	ICBO	1	l	-4.0	μΑ	$V_{CB} = -30V, T_A = 150^{\circ}C$	
Collector-Emitter Cut-Off Current (Note 5)	I _{CES}		I	-100	nA	V _{CE} = -45V	
Gain Bandwidth Product	f _T	100	_	_	MHz	V _{CE} = -5.0V, I _C = -10mA, f = 100MHz	
Output Capacitance	C _{OB}		I	4.5	pF	V _{CB} = -10V, f = 1.0MHz	
Noise Figure	NF			10	dB	$I_C = -0.2$ mA, $V_{CE} = -5.0$ Vdc,	
Noise rigure	INF			10	uБ	$R_S = 2.0K\Omega$, $f = 1.0KHz$, $BW = 200Hz$	

MOSFET









25

50

T_A, AMBIENT TEMPERATURE (°C)

Fig. 7 Gate Threshold Variation vs. Ambient Temperature

75

100

0.0001

0.1

0.5

0.7

 V_{SD} , SOURCE-DRAIN VOLTAGE (V)

Fig. 8 Diode Forward Voltage vs. Current



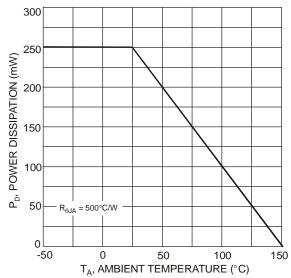


Fig. 9 Derating Curve - Total Package Power Dissipation

PNP Transistor

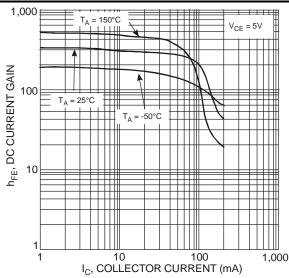


Fig. 10 Typical DC Current Gain vs. Collector Current

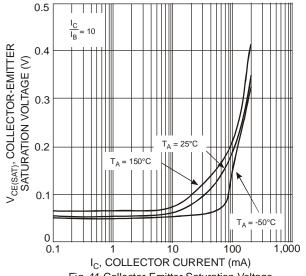


Fig. 11 Collector-Emitter Saturation Voltage vs. Collector Current

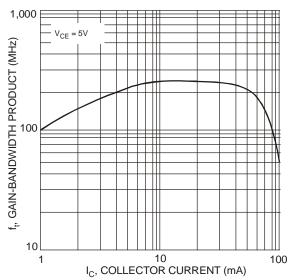
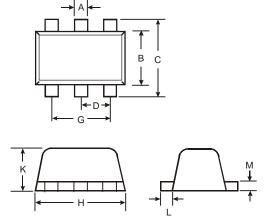


Fig. 12 Typical Gain-Bandwidth Product vs. Collector Current

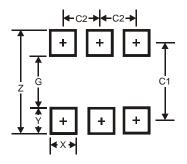


Package Outline Dimensions



SOT563						
Dim	Min	Max	Тур			
A	0.15	0.30	0.20			
В	1.10	1.25	1.20			
O	1.55	1.70	1.60			
ם	-		0.50			
G	0.90	1.10	1.00			
Н	1.50	1.70	1.60			
K	0.55	0.60	0.60			
L	0.10	0.30	0.20			
M	0.10	0.18	0.11			
All Dimensions in mm						

Suggested Pad Layout



Dimensions	value (in mm)
Z	2.2
G	1.2
Х	0.375
Υ	0.5
C1	1.7
C2	0.5



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